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File No. 4463 U.S. Pat. Appln. Ser. No. 09/762,863

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

JUN 25 Zalis

**APPLICANT:** 

Euler et al.

GROUP:

2877

TECHCENTER 2000

**SERIAL NO:** 

09/762,863

EXAMINER: Lee, A.

FILED:

May 2, 2001

FOR:

THIN FILM STRAIN SENSORS BASED ON

INTER-FEROMETRIC OPTICAL MEASUREMENTS

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

## **AMENDMENT**

In response to the Office Action mailed March 26, 2004, please amend the application as follows: